

MILITARY SPECIFICATION  
CONNECTORS, ELECTRIC, RECTANGULAR, NONENVIRONMENTAL,  
MINIATURE, POLARIZED SHELL, RACK AND PANEL,  
GENERAL SPECIFICATION FOR

This specification is approved for use by all Departments and  
Agencies of the Department of Defense.

1. SCOPE

1.1 Scope. This specification covers nonenvironmental, polarized shell, miniature, rack and panel connectors having pin and socket, crimp (removable), solder (nonremovable), or insulation displacement (nonremovable) contacts with rigid or float mounting, designed for -55°C to +125°C operating temperature.

1.2 Classification.

1.2.1 Classes. Connectors covered by this specification shall be of the following classes.

- G - General purpose connectors.
- N - Nonmagnetic connectors.
- H - Hermetic connectors.
- M - Same as N except see I/.
- D - Same as G except see T/.
- K - Same as H except see T/.

1.2.2 Style of termination. Connectors covered by this specification shall be of the following terminal types:

- Crimp
- Solder
- Insulation displacement contact (IDC)
- Printed wiring board (PWB)

1.2.3 Types. Connectors covered by this specification shall be of the following types:

- I - Standard density (size 20 contacts).
- II - High density (size 220 contacts).
- III - Standard density (size 20 IDC contacts).

1.2.4 Military part number. The military part number shall consist of the letter "M", the basic number of the specification sheet, and an assigned dash number (see 3.1) as shown in the following:

M	24308/1	-1
T	T	T
Military designation	Specification sheet number	Dash number

Example: M24308/1-1

I/ Classes D, K, and M are intended for spaceborne missions where high reliability is required.

Beneficial comments (recommendations, additions, deletions) and any pertinent data which may be of use in improving this document should be addressed to: Commander, Naval Electronic Systems Command, ATTN: ELEX 8111, Department of the Navy, Washington, DC 20363 by using the self-addressed Standardization Document Improvement Proposal (DD Form 1426) appearing at the end of this document or by letter.

## 2. APPLICABLE DOCUMENTS

2.1 Government specifications and standards. Unless otherwise specified, the following specifications and standards, of the issue listed in that issue of the Department of Defense Index of Specifications and Standards specified in the solicitation, form a part of this specification to the extent specified herein.

## SPECIFICATION

## FEDERAL

QQ-N-290	Nickel Plating (Electrodeposited).
QQ-P-35	Passivation Treatments for Corrosion-Resisting Steel.
QQ-P-416	Plating, Cadmium (Electrodeposited).

## MILITARY

MIL-M-14	Molding Plastics and Molded Plastic Parts, Thermosetting.
MIL-H-5606	Hydraulic Fluid, Petroleum Base; Aircraft Missile, and Ordnance.
MIL-T-10727	Tin Plating; Electrodeposited or Hot-Dipped, for Ferrous and Nonferrous Metals.
MIL-W-16878/4	Wire, Electrical, Polytetrafluoroethylene (PTFE) Insulated, 200°C, 600 Volts, Extruded Insulation.
MIL-I-17214	Indicator, Permeability, Low-mu (Go-No-Go)
MIL-C-22520	Crimping Tools, Terminal, Hand or Power Actuated, Wire Termination
MIL-L-23699	Lubricating Oil, Aircraft Turbine Engines, Synthetic Base.
MIL-M-24519	Molding Plastics, Polyester, and Polyarylether Thermoplastic.
MIL-C-26074	Coating, Electroless Nickel, Requirements for.
MIL-C-39029	Contacts, Electrical Connector, General Specification for.
MIL-G-45204	Gold Plating, Electrodeposited.
MIL-C-49055	Cables, Power, Electrical, (Flexible, Flat, Unshielded), Round Conductor, General Specification for.
MIL-C-55330	Connectors, Electrical and Fiber Optic, Packaging of.
MIL-P-81728	Plating, Tin Lead (Electrodeposited).
MIL-I-81969	Installing and Removal Tools, Connector Electrical Contact, General Specification for.

(See Supplement 1 for list of applicable specification sheets and military standards).

## STANDARDS

## MILITARY

MIL-STD-105	Sampling Procedures and Tables for Inspection by Attributes.
MIL-STD-202	Test Methods for Electronic and Electrical Component Parts.
MIL-STD-454	Standard General Requirements for Electronic Equipment.
MIL-STD-1285	Marking of Electrical and Electronic Part.
MIL-STD-1344	Test Methods for Electrical Connectors.
MIL-STD-45662	Calibration Systems Requirements.
MS14058	Connector, Electric, Rectangular, Miniature, Polarized Shell, Rack and Panel, Shell, Receptacle, Socket Contacts Straight, Printed Circuit Board Terminal Types.

MS14059

Connectors, Electric, Rectangular, Miniature, Polarized Shell, Rack and Panel, Shell, Plug, Pin Contacts, Printed Circuit Board Termination Types.

MS18281

Contacts, Pin and Socket, Classes G, N, and H, Solder Type, Non-removable.

SP-R-0022

Vacuum Stability Requirements of Polymeric Material for Spacecraft Applications.

(Copies of specifications, standards, handbooks, drawings, and publications required by manufacturers in connection with specific acquisition functions should be obtained from the contracting activity or as directed by the contracting officer.)

2.2 Other publications. The following document forms a part of this specification to the extent specified herein. The issues of the documents which are indicated as DoD adopted shall be the issue listed in the current DoDISS and the supplement thereto, if applicable.

American Society for Testing and Materials (ASTM)

ASTM B633

Zinc on Iron and Steel, Electrodeposited Coatings of.

(Application for copies should be addressed to American Society for Testing and Materials, 1916 Race Street, Philadelphia, PA 19103).

2.3 Order of precedence. In the event of a conflict between the text of this specification and the references cited herein, the text of this specification shall take precedence.

### 3. REQUIREMENTS

3.1 Specification sheets. The individual item requirements shall be as specified herein and in accordance with the applicable specification sheet. In the event of any conflict between the requirements of this specification and the specification sheet, the latter shall govern.

3.2 Qualification. Connector assemblies furnished under this specification shall be products which are qualified for listing on the applicable Qualified Products List at the time set for opening of bids (see 4.5 and 6.3).

3.3 Materials. Materials shall be as specified herein. However, when a definite material is not specified, a material shall be used which will enable the connectors to meet the performance requirements of this specification. Acceptance or approval of any constituent material shall not be construed as a guaranty for acceptance of the finished product.

3.3.1 Dissimilar metals. When dissimilar metals are employed in intimate contact with each other, protection against electrolytic corrosion shall be provided as specified in Requirement 16 of MIL-STD-454.

3.3.2 Nonmagnetic materials (Class N and M connectors). All parts used in class N and M connectors shall be made from materials which are classed as nonmagnetic (see 3.5.1).

3.3.3 Contact materials. Classes G, N, D and M contact bodies shall be made of suitably conductive copper based alloys. Class H and K contacts may be ferrous alloy material. All contacts shall be suitably protected from corrosion. When contacts are in-process plated in strip form, the absence of plating in the separation area is acceptable, provided the area is nonfunctional and any corrosion products formed as a result of salt spray testing (4.7.18) does not appear in contact mating or termination area.

3.3.3.1 Accessory members. Contact accessory members such as hoods, pressure members and retaining devices shall be made of corrosion resistant material or shall be suitably treated to resist corrosion.

3.3.3.2 Contact finish (solder contact). The finish on contact bodies shall be gold applied either overall or localized for Class G. The finish on contact bodies for Classes M, D, and K shall be gold applied overall. The finish on contact bodies for Class H shall be tin applied overall.

3.3.3.2.1 Overall finish. Contact bodies shall be overall gold-plated 50 microinches thick minimum in accordance with MIL-G-45204, Type II, Grade C, Class 1, over a suitable underplate. Silver shall not be used as an underplate. Nickel shall not be used as an underplate on Classes N and M. The finish on contact bodies of Class H connectors shall be 50 microinches minimum of electro-tin (no organic brighteners) in accordance with MIL-T-10727. Preliminary plating of another metal is permissible.

3.3.3.2.2 Localized finish. Contact bodies shall be overall nickel plated 30 to 150 microinches thick in accordance with QQ-N-290, Class 2.

3.3.3.2.2.1 Contact mating area. The contact mating area as shown in FIGURE 1 shall be gold plated 50 microinches thick minimum in accordance with MIL-G-45204, Type II, Grade C, Class 1 over nickel plating (see 3.3.3.2.2).

3.3.3.2.2.2 Terminations. Terminations shall be plated as follows:

a. Solder cups: 100 microinches minimum tin-lead plated in accordance with MIL-P-81728, 50 to 95 percent tin.

b. Insulation displacement: 100 microinches minimum tin-lead plated in accordance with MIL-P-81728, 50 to 95 percent tin.

c. Printed wiring tails: Dimension M as shown on MS14058 and MS14059, 100 microinches minimum tin-lead plated in accordance with MIL-P-81728.

#### 3.3.4 Dielectric materials.

3.3.4.1 Insert. Insert materials shall conform to Type SDG-F of MIL-M-14 or Type GPT-30F or GET-30F in accordance with MIL-M-24519, for Classes G, D, M and N connectors. Insert dielectric material for Class H and K shall be glass.

3.3.5 Metal components. Metal components shall be of high grade corrosion resistant material or a material treated to resist corrosion which will allow the complete connector assembly to meet the requirements of this specification.

3.3.5.1 Finish (Classes G, and N). Shells shall be cadmium plated in accordance with Type II, Class 2 of QQ-P-416 or zinc plated in accordance with ASTM B633. A preliminary plating of another metal is permissible. The resulting finish shall be electrically conductive, and shall be of a golden color to ensure that the chromate finish has been properly applied. Corrosion-resistant steel parts shall be passivated in accordance with QQ-P-35 and need not be overplated.

3.3.5.2 Finish for Class H connectors. Unless otherwise specified, all metal parts for Class H connectors shall be tin plated in accordance with MIL-T-10727. Preliminary plating of another metal is permissible.

3.3.5.3 Finish for Class D, M, and K connectors. All metal parts for Class D and K connectors shall be electrically conductive electroless nickel conforming to MIL-C-26074, Class 3 or 4, Grade B, finish shall be dull. Use of a suitable underplate is permissible. For Class M, the finish shall be gold in accordance with MIL-G-45204, Grade C, Class 1 over a suitable underplate. A silver underplate shall not be used.

3.4 Design, construction and physical dimensions. Connectors shall be of the design, construction and physical dimensions specified (see 3.1). Connectors shall be so designed that neither the pins nor the sockets will be damaged during normal mating of counterpart connectors.

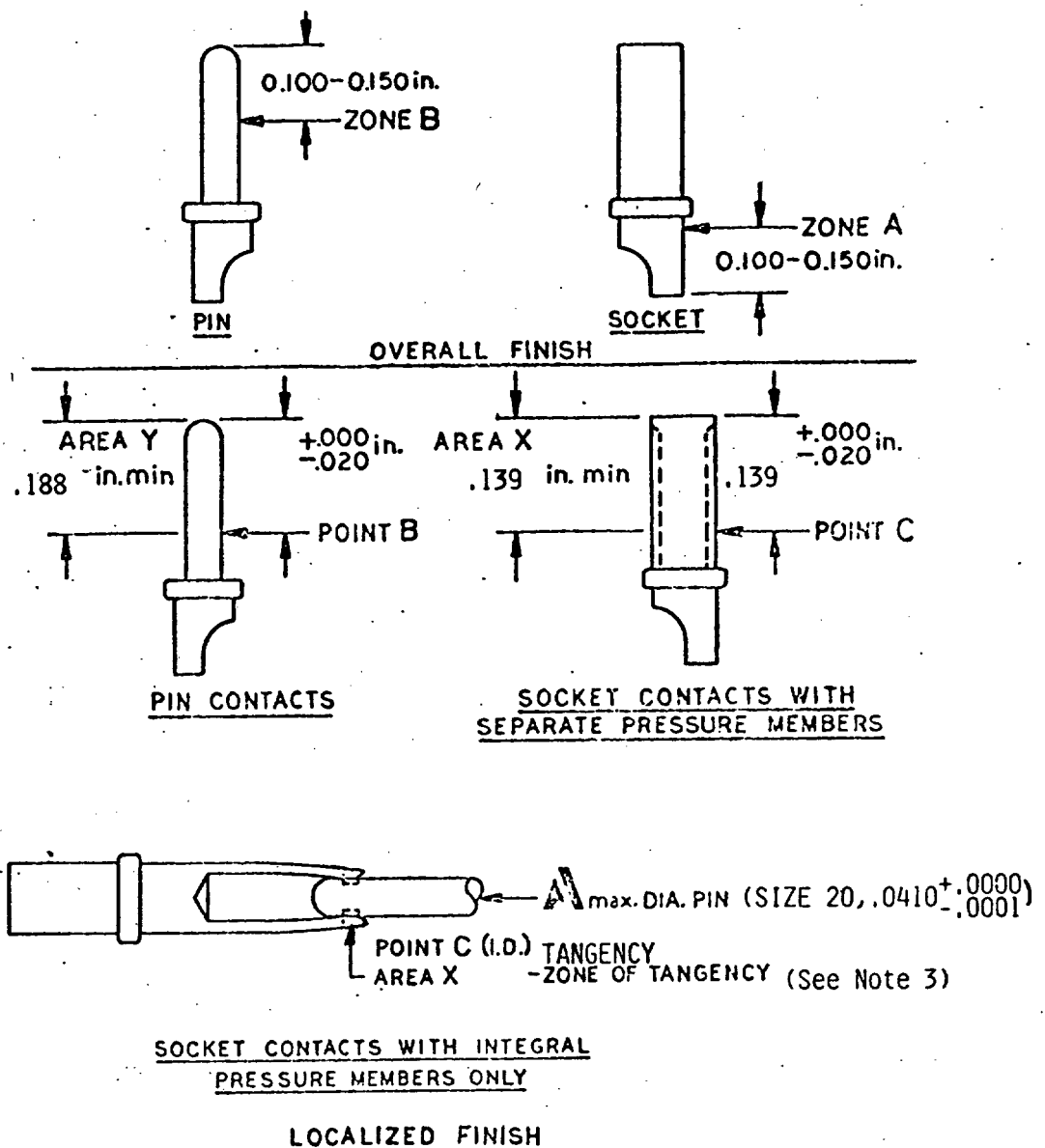


FIGURE 1. Gold thickness areas.

## NOTES:

1. Overall finish: Measure gold thickness in Zone A or B, as applicable.
2. Localized finish: Apply gold to the inside and outside diameter of the contact in Area X or Y. Measure gold thickness on outside diameter of the contact at Point B or C, as applicable.
3. On socket contacts with integral pressure members Area X (zone of tangency) extends from the tip of the contact to .020 inch beyond the point of tangency, Point C on the inside and outside diameter of the contact.

3.4.1 Contact design. Contacts shall be as specified on individual standards or military specification sheets (see 3.1).

3.4.1.1 Solder contacts. Solder contacts shall be nonremovable from the insert, shall have eyelet or solder cup terminals as specified (see 3.1) and shall be in accordance with MS18281. Solder cups shall be so designed that during soldering, no components will be damaged and no liquid solder shall escape.

3.4.1.2 Crimp contacts. Crimp contacts shall be as follows:

<u>Connector density</u>	<u>Contact size</u>	<u>Contact part number</u>
High	22D pin	M39029/57-354
High	22D socket	M39029/58-360
Standard	20 pin	M39029/64-369
Standard	20 socket	M39029/63-368

3.4.1.2.1 Contact insertion and removal tools. Crimp removable connectors shall be designed for contact insertion and removal with the applicable military tools as follows:

<u>Contact size</u>	<u>Tool part number</u>
22D	M81969/14-01 M81969/1-04
20	M81969/14-02 M81969/1-02

3.4.1.3 Class H and K contacts. Class H and K contacts shall be permanently fused in place and shall have eyelet or solder cup terminals, as specified (see 3.1), in accordance with MS18281.

3.4.1.4 Insulation displacement contacts. Insulation displacement contacts shall be non-removable from the insert and shall be as specified (see 3.1).

3.4.2 Insert design and construction. Inserts shall be designed with suitable sections and radii such that they will not readily chip, crack, or break in assembly or in normal service. Inserts shall be molded or bonded one-piece construction, (except for IDC). Pin entry openings on socket insert faces shall be as small as practicable. Socket inserts shall provide adequate protection against a pin contacting a socket before the mating pair of connectors has been polarized. The inserts shall be so designed that the inserts cannot be removed from the shells. The contact retaining system for removable crimp contact connectors shall be free of foreign material, adhesive, or any obstruction that would prevent smooth contact insertion and positive retention. The contact retention system for removable crimp contact connectors shall be a metal retention clip.

3.4.2.1 Insert arrangement. The insert arrangement shall be as specified by the connector part number (see 3.1).

3.4.2.2 Contact alignment and stability. With all contacts in place, the alignment of pin and socket contacts shall always permit engagement irrespective of buildup of allowable tolerances on hole locations, distortion of contacts due to crimping, and insert location in the shell.

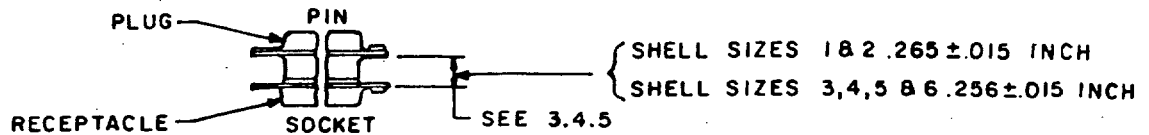
3.4.3 Shell design. The shell shall be designed to positively retain the insert and shall be so constructed that the insert cannot be removed.

3.4.3.1 Shell polarization. Polarization shall be accomplished by a keystone shape shell design with polarization accomplished before engagement of the pins and sockets.

3.4.3.2 Mounting. Connectors shall be provided with means to fasten the shell securely to a mounting surface. Class H and K connectors shall be provided with solder mounting provisions, or with provisions for external mounting hardware (see 3.1).

3.4.4 Interchangeability. All connectors having the same military part number shall be completely interchangeable with each other with respect to installation (physical) and performance (function) as specified herein. Solder and crimp contact connectors shall be interchangeable (see 3.1).

3.4.5 Mated spacing. Connectors shall meet applicable performance requirements when mated within the spacing shown below.



3.5 Performance. Connectors shall be designed to meet the performance requirements specified herein.

3.5.1 Magnetic permeability (Classes N and M). The relative permeability of Class N and M connectors shall not exceed 2 mu when measured as specified in 4.7.2.

3.5.2 Maintenance aging (crimp type). All crimp-contact connectors shall be capable of conforming to the requirements of 3.5.3 and 3.5.4 after maintenance aging of 4.7.3.

3.5.3 Contact insertion and removal forces. The axial forces required to insert and remove removable contacts shall conform with the applicable requirements of TABLE I when tested in accordance with 4.7.4.

TABLE I. Contact insertion and removal forces (pounds maximum).

	Contact size	
	20	22D
Insertion	3	3 <sup>1/</sup>
Removal	4	4

<sup>1/</sup> For shell size 5, 78 pin layout, 4 pounds maximum

3.5.4 Mating and unmating force. The force for mating and unmating of counterpart connectors shall meet the requirements of TABLE II. The connectors used in this test shall have the complete complement of contacts. Testing shall be as specified in 4.7.5.

TABLE II. Mating and unmating forces (pounds).

Shell size	Unmating				Mating	
	Minimum		Maximum		Maximum	
	Class		Class		Class	
	G, D, M, N	H, K	G, D, M, N	H, K	G, D, M, N	H, K
1	0.75	1.50	6.0	7.00	10.0	7.25
2	1.00	2.00	10.0	13.00	17.0	13.00
3	1.75	3.25	17.0	21.25	28.0	21.25
4	2.50	4.50	24.0	31.25	39.0	31.25
5	3.25	5.50	30.0	42.25	49.0	42.25
6	4.50	----	39.0	-----	65.0	-----

3.5.5 Contact retention. Contacts for Classes G, D, M, and N connectors shall be retained in their inserts by a 9 pound (minimum) force. The axial displacement of contacts shall not exceed 0.012 inch while under load (see 4.7.6).

3.5.6 Dielectric withstanding voltage. Unmated connectors shall show no evidence of breakdown or flashover when subjected to the test voltages and altitude of TABLES III and IV. Corona shall not be considered as breakdown. Testing shall be as specified in 4.7.7.

TABLE III. Type I and II test voltage (rms 60 hertz ac volts). <sup>1/</sup>

Altitude	Humidity conditioned (see 4.7.13)		All other conditions	
	Class G, D, M, N	Class H, K	Class G, D, M, N	Class H, K
Sea level 70,000 feet	600 ---	400 ---	1000 325	750 175

<sup>1/</sup> These are not working voltages.

TABLE IV. Type III test voltage (rms 60 hertz ac volts). <sup>1/</sup>

Altitude	Humidity conditioned (see 4.7.13)	All other conditions
	Class G	
Sea level 70,000 feet	500 ---	500 200

<sup>1/</sup> These are not working voltages.

3.5.7 Cable retention (flat cable only). When connectors are tested as specified in 4.7.8, they shall withstand the minimum applied force without mechanical damage.

3.5.8 Insulation resistance at ambient temperature. The insulation resistance of unmated connectors shall conform with the applicable requirements of TABLE V when tested in accordance with 4.7.9.

TABLE V. Insulation resistance.

Humidity conditioned (see 4.7.13)		All other conditions
After step 6 of Method 1002 of MIL-STD-1344	After 24 hours of conditioning (Method 1002 of MIL-STD-1344)	
Megohms (min)	Megohms (min)	Megohms (min)
1	1000	5000

3.5.9 Contact resistance (nonremovable contacts). Contact resistance for mated pairs of pin and socket contacts shall be as required by TABLE VI when tested in accordance with 4.7.10.



TABLE VI. Contact resistance (millivolts maximum).

Solder contact type	AWG wire size	Test current (amps)	Contacts			
			Class			
			G, D, M, N		H, K	
			After salt spray	All others	After salt spray	All others
20	24	3.0	65	55	---	---
	20	7.5	55	45	---	---
	24	2.0	--	--	ind 165	ind 165
	20	5.0	--	--	avg 90	avg 70
IDC	28	1.0	75	65	---	---

3.5.10 Contact engagement and separation forces (nonremovable contacts). Socket contacts shall conform with the forces specified in TABLE VII when tested in accordance with 4.7.11.

TABLE VII. Contact engagement and separation forces (ounces).

Initial			
Solder contact size	Maximum individual engagement force (ozs) using maximum diameter test pin	Maximum average engagement force (ozs) using maximum diameter test pin	Minimum separation force (ozs) using minimum diameter test pin
22D	12.0	9.5	0.7
20	18.0	12.0	0.7
IDC	18.0	12.0	0.7

After conditioning			
Solder contact size	Maximum individual engagement force (ozs) using maximum diameter test pin	Maximum average engagement force (ozs) using maximum diameter test pin	Minimum separation force (ozs) using minimum diameter test pin
22D	14	11.4	0.6
20	22	14	0.6
IDC	22	14	0.6

3.5.11 Temperature cycling. There shall be no damage detrimental to the operation of the connector after being subjected to the temperature extremes of TABLE VIII in accordance with 4.7.12.

TABLE VIII. Temperature extremes.

Extremes	°C
Low	-55+0 -3
High	+125+3 -0

3.5.11.1 Temperature cycling (Classes D, K, and M). There shall be no damage detrimental to the connectors operation after being subjected to testing in accordance with 4.7.12.1. Following the test, the connectors shall withstand the sea level dielectric withstanding voltage specified in TABLE III.

3.5.12 Air leakage (class H and K connectors). When tested as specified in 4.7.13, the air leakage rate of class H and K connectors shall be no greater than one micron cubic foot per hour at a differential of one atmosphere ( $1.04 \times 10^{-5}$  atmospheres  $\text{cm}^3/\text{s}$ ). The specified leakage rate shall apply only through the connector and not through the flange to the mounting surface joint.

3.5.13 Humidity. Connectors shall meet the applicable dielectric withstanding voltage and insulation resistance requirements (see 3.5.6 and 3.5.8) when tested as specified in 4.7.14.

3.5.14 Vibration. Mated connectors shall not be damaged and there shall be no loosening of parts due to vibration. Counterpart connectors shall be retained in engagement and there shall be no interruption of electrical continuity or current flow longer than 1 microsecond when tested as specified in 4.7.15.

3.5.15 Shock. Mated connectors shall not be damaged and there shall be no loosening of parts, nor shall there be an interruption of electrical continuity or current flow longer than 1 microsecond during the exposure to mechanical shock, as specified in 4.7.16.

3.5.16 Durability. Counterpart connectors shall show no mechanical or electrical defects detrimental to the operation of the connector as specified in 3.5.4 and 3.5.10 after 500 cycles of mating and unmating as specified in 4.7.17.

3.5.17 Salt spray (corrosion). Mated connectors shall show no exposure of base metal due to corrosion which will affect performance as specified in accordance with 3.5.4 and 3.5.8, when tested as specified in 4.7.18.

3.5.18 Oversize pin exclusion (nonremovable contacts). Socket contacts shall exclude the entry of the test pin indicated in TABLE IX when tested as specified in 4.7.19. After testing, the contacts shall meet the contact resistance requirements of 3.5.9.

TABLE IX. Oversize pin exclusion.

Contact size	Pin diameter inches
20	.046

3.5.19 Resistance to test probe damage (nonremovable contacts). Socket contacts shall meet the engaging and separating force requirements of 3.5.10 and shall show no evidence of visible damage when tested as specified in 4.7.20.

3.5.20 Fluid immersion. Connectors shall mate within the forces specified in 3.5.4 after being subjected to the fluid immersion test of 4.7.21.

3.5.21 Insert retention.

3.5.21.1 Insert retention (Classes G, D, M, and N). Inserts shall not be dislocated from their original positions with an axial load of 60  $\text{lb/in}^2$  applied as specified in 4.7.22.

3.5.21.2 Insert retention (Classes H and K). Class H and K inserts shall not be dislocated from their original positions or damaged when an effective pressure differential of 200  $\text{lb/in}^2$  is applied as specified in 4.7.22.

3.5.22 Contact pin strength. Nonremovable contact pin strength shall be such that a force of 2 pounds  $\pm$  1 ounce will not produce a permanent set in excess of .005 inch when tested as specified in 4.7.24.

3.5.23 Solderability. Terminations shall withstand the test specified in 4.7.23. Printed wiring tails shall meet the solderability requirements of MIL-STD-202, Method 208.

3.5.24 Thermal vacuum outgassing (Classes D, K, and M). The entire connector assembly, when tested in accordance with 4.7.2.5, shall have maximum total mass loss (TML) of 1.0 percent of the original specimen mass and shall have a maximum volatile condensable material (VCM) content of 0.1 percent of the original specimen mass.

**3.6 Marking.** Connectors shall be marked in accordance with Method 1 of MIL-STD-1285, and shall include the military part number (see 3.1), the manufacturer's name or code symbol, and date code.

**3.6.1 Insert marking.** Raised or depressed characters may be used. Markings are shown on the applicable military specification sheet or standard. Socket face and pin face are opposite. On insulation displacement connectors, contact markings shall appear on both sides of the insert. First and last pin number of each row should be marked clearly on the housing.

**3.6.1.1 Contact designations.** All contact locations shall be designated by identifiable characters on the front and rear faces of the insert or insert assembly. Positioning and arrangement of the characters shall be such that the corresponding contact location may be readily identifiable. Connector shell marking and insert marking shall remain legible after completion of the tests specified in 4.5.

**3.6.2 Connector kit package.** Each connector kit package shall contain a removable contact connector (marked with the complete connector part number), a full complement of contacts for the connector, and an applicable insertion/removal tool as required by the detail specification sheet (see 3.1).

**3.7 Workmanship.** Connectors shall be processed in such a manner as to be uniform in quality and shall be free from burrs, crazing, cracks, voids, pimples, chips, blisters, pin holes, sharp cutting edges, and other defects that will adversely affect life, serviceability, or appearance. Sharp cutting edges are acceptable on the terminations of IDC connectors.

#### 4. QUALITY ASSURANCE PROVISIONS

**4.1 Responsibility for inspection.** Unless otherwise specified in the contract, the contractor is responsible for the performance of all inspection requirements as specified herein. Except as otherwise specified in the contract, the contractor may use his own or any other facilities suitable for the performance of the inspection requirements specified herein, unless disapproved by the Government. The Government reserves the right to perform any of the inspections set forth in the specification where such inspections are deemed necessary to assure supplies and services conform to prescribed requirements.

**4.1.1 Test equipment and inspection facilities.** Test and measuring equipment and inspection facilities of sufficient accuracy, quality and quantity to permit performance of the required inspection shall be established and maintained by the contractor. The establishment and maintenance of a calibration system to control the accuracy of the measuring and test equipment shall be in accordance with MIL-STD-45662.

**4.1.2 Assembly plants.** Assembly plants must be listed on or approved for listing on the applicable Qualified Products List. The qualified connector manufacturer shall certify that the assembly plant is approved for the assembly and distribution of the manufacturer's parts. The assembly plant shall use only piece parts supplied by the qualified connector manufacturer. No testing other than visual examination is required of certified piece parts obtained from the qualified connector manufacturer, except when there is cause for rejection. All assemblies produced at the assembly plant shall be subjected to examination of product to assure that the assembly process conforms with that established at the qualified manufacturing plant. Quality control requirements, including Government inspection surveillance, shall be the same as required for the qualified connector manufacturer.

**4.2 Classification of inspections.** The inspections specified herein are classified as follows:

- a. Materials inspection (see 4.3).
- b. Qualification inspection (see 4.5).
- c. Quality conformance inspection (see 4.6).

**4.3 Materials inspection.** Materials inspection shall consist of certification supported by verifying data that the materials, as specified herein and on the specification sheet (see 3.1), used in fabricating the connectors, are in accordance with the applicable specifications including quality assurance provisions and referenced inspections and requirements prior to such fabrication.

4.4 Inspection conditions. Unless otherwise specified herein, all inspections shall be performed in accordance with the test conditions specified in the "GENERAL REQUIREMENTS" of MIL-STD-1344 and MIL-STD-202.

4.5 Qualification inspection. Qualification inspection shall be performed at a laboratory acceptable to the Government (see 6.3) on sample units produced with equipment and procedures normally used in production.

4.5.1.1 Connectors. A minimum of six completely assembled plugs and receptacles of the class (1.2.1) with the insert arrangement of the largest size connector of the type (1.2.3) with the same style of termination (1.2.2) for which qualification is desired, shall be subjected to the examinations and tests, except for thermal vacuum outgassing, in the sequence shown in TABLE XI. For Classes D, M, and K, all the non-metallic materials, including lubricants, of two additional connectors shall be subjected to the thermal vacuum outgassing test. If Classes G and N or M and D are being qualified at the same time, a minimum of three completely assembled plugs and receptacles with the insert arrangement of the largest size connector of the type (1.2.3) with the same style of termination (1.2.2) of each class (Classes G and N, 3 Class G, 3 Class N; Classes M and D, 3 Class M, 3 Class D) shall be subjected to the examinations and tests, except for thermal vacuum outgassing, in the sequence shown in TABLE XI. For Classes D and M, all the non-metallic materials, including lubricants, of one additional connector of each class shall be subjected to the thermal vacuum outgassing test. The connectors shall have a full complement of contacts. Half of the Class H and Class K contacts shall have solder cups and the remainder shall have eyelets. The samples subjected to qualification testing shall be provided with counterpart connectors for those tests requiring mating assemblies. The counterpart connectors provided for this purpose shall be new, previously qualified connectors or new connectors submitted for qualification testing. Suppliers not producing mating connectors shall submit substantiating, certification data that tests were performed with qualified counterpart connectors. The samples shall be taken from a production run and shall be produced with equipment and procedures normally used in production.

4.5.1.2 Qualification of additional connectors. For all other connector sizes of the same type, class, and style of termination for which qualification is desired, two each of the completely assembled plugs and receptacles shall be subjected to the examinations and tests in the sequence shown in TABLE XI. Mating plugs and receptacles shall be furnished.

4.5.1.3 Preparation of samples. Connectors shall be wired with approximately 2 feet of wire conforming to MIL-W-16878/4 and TABLE X. Half of the connectors of each type shall be wired with the maximum wire size and the remainder shall be wired with the minimum wire size specified in TABLE X. Termination of wires to contacts shall be accomplished as follows: A MIL-C-22520/2 crimping tool (see 3.1), shall be used for removable contacts. Soldering shall be in accordance with Requirement 5 of MIL-STD-454 for nonremovable contacts. Insulation displacement connectors shall use cable in accordance with MIL-C-49055.

TABLE X. Test wire sizes.

Contact size	Maximum wire size	Minimum wire size
20 22D	20 22	24 28
10C	28 stranded	28 stranded

4.5.2 Inspection routine. The sample shall be subjected to the inspections specified in TABLE XI in the order shown. All sample units shall be subjected to visual and mechanical inspection before wiring (see 4.5.1.2 and 4.7.1).

4.5.3 Failures. One or more failures shall be cause for refusal to grant qualification approval.

TABLE XI. Qualification inspection. <sup>1/</sup>

Inspection	Requirement paragraph	Test method paragraph	Connector class <sup>2/</sup>				
			1	2	3	4	5
Visual and mechanical inspection	3.1, 3.3, 3.4, 3.6 and 3.7	4.7.1	X	X	X	X	X
Magnetic permeability (Classes N and M) <sup>3/</sup>	3.5.1	4.7.2			X	X	
Maintenance aging (crimp type)	3.5.2	4.7.3	X		X		
Contact insertion and removal forces	3.5.3	4.7.4	X		X		
Mating and unmating force	3.5.4	4.7.5	X		X		
Contact retention	3.5.5	4.7.6	X	X	X	X	
Dielectric withstanding voltage: <sup>3/</sup>							
At sea level	3.5.6	4.7.7.1	X	X	X	X	X
At altitude	3.5.6	4.7.7.2	X	X	X	X	X
Cable retention (flat cable only)	3.5.7	4.7.8	X	X	X	X	X
Insulation resistance at ambient temperature <sup>3/</sup>	3.5.8	4.7.9	X	X	X	X	X
Contact resistance (nonremovable contacts)	3.5.9	4.7.10	X	X	X	X	X
Contact engagement and separation forces (nonremovable contacts)	3.5.10	4.7.11		X		X	X
Mating and unmating force	3.5.4	4.7.5	X	X	X	X	X
Temperature cycling (Classes G, N, and H)	3.5.11	4.7.12	X	X	X	X	X
Temperature cycling (Classes D, M, and K)	3.5.11.1	4.7.12.1	X	X	X	X	X
Air leakage (Classes H and K)	3.5.12	4.7.13					X
Humidity	3.5.13	4.7.14	X	X	X	X	X
Dielectric withstanding voltage	3.5.6	4.7.7	X	X	X	X	X
Insulation resistance	3.5.8	4.7.9	X	X	X	X	X
Vibration	3.5.14	4.7.15	X	X	X	X	X
Shock	3.5.15	4.7.16	X	X	X	X	X
Durability	3.5.16	4.7.17	X	X	X	X	X
Contact engagement and separation forces	3.5.10	4.7.11		X		X	X
Mating and unmating force	3.5.4	4.7.5	X	X	X	X	X
Salt spray (corrosion)	3.5.17	4.7.18	X	X	X	X	X
Contact resistance (nonremovable contacts)	3.5.9	4.7.10	X	X	X	X	X
Mating and unmating force	3.5.4	4.7.5	X	X	X	X	X
Contact retention	3.5.5	4.7.6	X	X	X	X	
Oversize pin exclusion (nonremovable contacts)	3.5.18	4.7.19	X	X	X	X	
Contact resistance (nonremovable contacts)	3.5.9	4.7.10	X	X	X	X	
Resistance to test probe damage (nonremovable contacts)	3.5.19	4.7.20	X	X	X	X	
Contact engagement and separation forces (nonremovable contacts)	3.5.10	4.7.11		X		X	
Fluid immersion <sup>3/</sup>	3.5.20	4.7.21	X	X	X	X	X
Mating and unmating force <sup>3/</sup>	3.5.4	4.7.5	X	X	X	X	X
Insert retention	3.5.21	4.7.22	X	X	X	X	X
Contact pin strength	3.5.22	4.7.24	X	X	X	X	X
Solderability	3.5.23	4.7.23	X	X	X	X	X
Visual and mechanical inspection	3.1, 3.3, 3.4, 3.6 and 3.7	4.7.1	X	X	X	X	X
Thermal vacuum outgassing (Classes D, M, and K) <sup>4/</sup>	3.5.24	4.7.25	X	X	X	X	X

<sup>1/</sup> IDC connectors shall meet the test requirements specified for Class G and D nonremovable contact connectors.

<sup>2/</sup> Connector class:

1. Class G and D - Removable contact connectors.
2. Class G and D - Nonremovable contact connectors.
3. Class N and M - Removable contact connectors.
4. Class N and M - Nonremovable contact connectors.
5. Class H and K - Nonremovable contact connectors.

<sup>3/</sup> Not applicable for periodic inspection.

<sup>4/</sup> See 4.5.1.1 (non-metallic materials of two connector assemblies).

4.5.4 Retention of qualification. To retain qualification, the contractor shall forward a report at 12 month intervals to the qualifying activity. The qualifying activity shall establish the initial reporting date. The report shall consist of:

a. A summary of the results of the tests performed for inspection of product for delivery (Group A), indicating as a minimum the number of lots that have passed and the number that have failed. The results of tests of all reworked lots shall be identified and accounted for.

b. The results of tests performed for periodic inspection (Group B), including the number and mode of failures. The test report shall include results of all periodic inspection tests performed and completed during the period. If the test results indicate nonconformance with specification requirements, and corrective action acceptable to the qualifying activity has not been taken, action may be taken to remove the failing product from the qualified products list.

Failure to submit either report within 30 days after the end of each reporting period may result in loss of qualification for the product. In addition to the periodic submission of inspection data, the contractor shall immediately notify the qualifying activity at any time during the reporting period that the inspection data indicates failure of the qualified product to meet the requirements of this specification.

In the event that no production occurred during the reporting period, a report shall be submitted certifying that the company still has the capabilities and facilities necessary to produce the item. If during the reporting period there has been no production, the manufacturer may be required, at the discretion of the qualifying activity, to submit the product to testing in accordance with the qualification inspection requirements.

#### 4.6 Quality conformance inspection.

4.6.1 Inspection of product for delivery. Inspection of product for delivery shall consist of Group A inspection.

4.6.1.1 Inspection lot. An inspection lot shall consist of all connectors or removable crimp contacts, as applicable, covered by one specification sheet, produced under essentially the same conditions, and offered for inspection at one time.

4.6.1.2 Group A inspection. Group A inspection shall consist of the inspections specified in TABLE XII, in the order shown.

4.6.1.2.1 Sampling plan. Statistical sampling and inspection shall be in accordance with MIL-STD-105 for general inspection level II. Major and minor defects shall be as defined in MIL-STD-105. The AQL shall be 1.0 percent for major defects and 4.0 percent for minor defects.

4.6.1.2.2 Rejected lots. If an inspection lot is rejected, the contractor may rework it to correct the defects, or screen out the defective units, and resubmit for reinspection. Resubmitted lots shall be inspected using tightened inspection. Such lots shall be separate from new lots, and shall be clearly identified as reinspected lots.

4.6.2 Retention of qualification. Retention of qualification inspection on connectors shall consist of the examinations and tests shown in TABLE XI. Shipment shall not be held up pending the results of this inspection.

4.6.3 Periodic inspection. Periodic inspection shall consist of Group B inspection. Except where the results of this inspection show noncompliance with the applicable requirements (4.6.2.1.4), delivery of products which have passed Group A shall not be delayed pending the results of this periodic inspections.

4.6.3.1 Group B inspection. Group B inspection shall consist of the inspections specified in TABLE XI in the order shown. Group B inspection shall be made on sample units which have been subjected to and have passed the Group A inspection.



TABLE XII. Group A inspection.

Inspection	Requirement paragraph	Test method paragraph
Visual and mechanical inspection	3.1, 3.3, 3.4, 3.6 and 3.7	4.7.1
Contact engagement and separation forces (nonremovable contacts)	3.5.10	4.7.11
Insulation resistance at ambient temperature	3.5.8	4.7.9
Dielectric withstanding voltage (sea level)	3.5.6	4.7.7

4.6.3.1.1 Sampling plan. Sample connectors consisting of two mated pairs of each class, of each type, of each style of termination of each size and all the non-metallic materials, including lubricants, of one connector of Class D, M, and K for which retention of qualification is desired shall be selected every 24 months. Upon passing this inspection two consecutive times, the contractor may select sample connectors every 36 months. If production of a particular part number is not current, the Group B tests must take place at the time production is resumed. The testing shall revert to the original schedule which is applied to a newly qualified product. If Group B testing on Classes G and N, D and M, or G, N, D, M is desired, one completely assembled plug and receptacle of each class shall be subjected to the examinations and tests in lieu of two of a single class.

4.6.3.1.2 Failures. If any sample units fail to pass Group B inspection, the entire sample shall be considered to have failed.

4.6.3.1.3 Disposition of sample units. Sample units which have been subjected to Group B inspection shall not be delivered on the contract.

4.6.3.1.4 Noncompliance. If a sample fails to pass Group B inspection, the manufacturer shall notify the qualifying activity and the cognizant inspection activity of such failure and take corrective action on the materials or processes, or both, as warranted, and on all units of product which can be corrected and which were manufactured under essentially the same materials and processes, and which are considered subject to the same failure. Acceptance and shipment of the product shall be discontinued until corrective action, acceptable to the qualifying activity has been taken. After the corrective action has been taken, Group B inspection shall be repeated on additional sample units (all inspections, or the inspection which the original sample failed, at the option of the qualifying activity). Group A inspection may be reinstituted; however, final acceptance and shipment shall be withheld until the Group B inspection has shown that the corrective action was successful. In the event of failure after inspection, information concerning the failure shall be furnished to the cognizant inspection activity and the qualifying activity.

4.6.4 Packaging inspection. The sampling and inspection of the preservation, packing, and container marking shall be in accordance with the requirements of MIL-C-55330.

#### 4.7 Methods of inspection.

4.7.1 Visual and mechanical inspection. Connectors and contacts shall be examined to verify that the dimensions, materials, design, construction, marking, and workmanship are in accordance with the applicable requirements (see 3.1, 3.3, 3.4, 3.6, and 3.7).

4.7.2 Magnetic permeability (Classes N and M) (see 3.5.1). Permeability shall be measured on Class N and M connectors with an instrument conforming to MIL-I-17214. The connectors may be wired or unwired, but shall not be carrying current. Requirements shall be as specified in 3.5.1.

4.7.3 Maintenance aging (crimp contact connectors only)(see 3.5.2). Connectors shall be tested in accordance with Method 2002 of MIL-STD-1344. Installing/removal tool shall be in accordance with the applicable specification sheet (see 3.1).

4.7.4 Contact insertion and removal forces (see 3.5.3). Contacts shall be inserted and removed in accordance with Method 2012 of MIL-STD-1344. Installing/removal tools shall be in accordance with the applicable specification sheet (see 3.1).

4.7.5 Mating and unmating force (see 3.5.4). Mated connectors shall be tested in accordance with Method 2013 of MIL-STD-1344. The rate of mating and unmating shall be 1 to 10 inches per minute.

4.7.6 Contact retention (see 3.5.5). Connectors shall be tested in accordance with Method 2007 of MIL-STD-1344. The following details shall apply:

- a. Axial direction - Shall be applied in both directions.
- b. Axial load - As specified.

4.7.7 Dielectric withstanding voltage (see 3.5.6).

4.7.7.1 Sea level. Unmated connectors shall be tested in accordance with Method 3001, Condition I, of MIL-STD-1344. The applicable test voltages specified in 3.5.6 shall be applied between all adjacent contacts and between the shell and each peripheral contact. Requirements shall be as specified in 3.5.6. For Group A inspection testing, voltage may be applied for a minimum of 10 seconds.

4.7.7.2 Altitude. The connectors shall be tested in accordance with Method 3001, Condition IV, of MIL-STD-1344. After 5 minutes at the simulated altitude, the connectors shall be tested as specified in 4.7.7.1.

4.7.8 Cable retention (flat cable only) (see 3.5.7). The unmated wired connector with strain relief, when applicable, shall be mounted by normal mounting means and aligned with the test fixture. An axial force of 8 ounces per contact shall be applied. The force shall be applied 6 inches from the mating face of the connector to the cable and shall pull away from the connector in a direction that will put the maximum stress on the contact-cable interface.

4.7.9 Insulation resistance at ambient temperature (see 3.5.8). Unmated connectors shall be tested in accordance with Method 3003, Test Condition B, of MIL-STD-1344. The resistance shall be measured between 50 percent, but not less than four pairs of adjacent contacts and between 50 percent, but not less than six contacts adjacent to the shell and the shell. The contacts selected shall be those having the closest spacing between measurement points and the measured resistance shall be as required by 3.5.8.

4.7.10 Contact resistant (nonremovable contacts) (see 3.5.9). Contacts shall be tested in accordance with Method 3004 of MIL-STD-1344. The following details apply:

- a. Wire size - As specified (see 3.1).
- b. Preparation - Connectors mated.
- c. Test current - Maximum contact current rating (see 3.5.9).
- d. Test circuit for nonremovable and Class H and K connectors shall be as shown in Method 3004. Test circuit for IDC connectors shall be as shown on FIGURE 2.

4.7.10.1 Class H and K pin contacts. Class H and K pin contacts shall be mated with counterpart copper based alloy socket contacts for the test of 4.7.10.



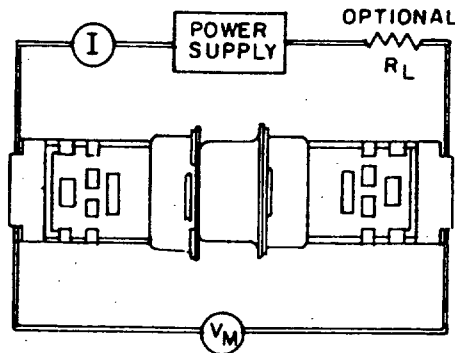


FIGURE 2. Contact resistance test circuit for IDC connectors.

**4.7.11 Contact engagement and separation forces (nonremovable contacts) (see 3.5.10).** Contact engagement and separation forces shall be tested in accordance with Method 2014 of MIL-STD-1344. The following details apply:

a. Insert and separate a maximum diameter pin in and from each socket contact, then insert and remove a minimum diameter pin in the same sockets. During separation of the minimum diameter test pin, the minimum separation force shall conform to 3.5.10.

b. Insert and separate a maximum diameter pin in and from each socket contact three times. During the third cycle, the engagement force shall conform to 3.5.10.

**4.7.12 Temperature cycling (Classes G, N and H) (see 3.5.11).** Unmated connectors shall be tested in accordance with Method 1003, Test Condition A, of MIL-STD-1344, except that the minimum temperature shall be as specified in TABLE VIII. At the completion of the last cycle, the connectors shall be returned to room temperature for further examination and shall meet the requirements of 3.5.11.

**4.7.12.1 Temperature cycling (Classes D, M and K) (see 3.5.11.1).** Mated connectors shall be tested in accordance with Method 1003, Test Condition A of MIL-STD-1344, except that the minimum temperature shall be as specified in TABLE VIII. At the completion of the last cycle, the connectors shall be returned to room temperature for further examination and shall meet the requirements of 3.5.11.1.

**4.7.13 Air leakage (Classes H and K connectors) (see 3.5.12).** Class H and K connectors shall be mounted in a manner suitable for application of one atmosphere pressure differential across the connectors, and tested in accordance with Method 1008, Test Condition C, of MIL-STD-1344. The leakage rate shall be determined while pressurized air or gas, containing not less than 10 percent helium by volume, is applied to the connector. Requirements shall be as specified in 3.5.12.

**4.7.14 Humidity (see 3.5.13).** The connectors shall be fully wired. The unmated and wired connectors shall be subjected to a humidity test in accordance with Method 1002, Test Condition II, of MIL-STD-1344 and with the following exceptions and details as required by 3.5.13.

a. Step 7B, vibration, is not required:

b. Upon completion of step 6 of the final cycle, connectors shall be removed from the chamber and surface moisture removed from the insulators. Immediately following removal of surface moisture, the insulation resistance test (see 4.7.9) and the sea level dielectric withstanding voltage test (see 4.7.7.1) shall be conducted.

c. After the 24 hour conditioning period, the insulation resistance shall again be measured.

4.7.15 Vibration (see 3.5.14). The connector assembly shall be mounted, as specified herein and vibrated in accordance with Method 2005, Test Condition 4, of MIL-STD-1344. All contacts shall be wired in series with at least 100 milliamperes of current allowed to flow. A suitable instrument shall be employed to monitor the current flow and to indicate any discontinuity of contact or interruption of current flow. Requirements shall be as specified in 3.5.14.

4.7.15.1 Connector mounting. Each receptacle shall be mounted on a suitable fixture, which in turn shall be attached to a vibration table. A suitable sensor shall monitor the receptacles at a point on or near the receptacle. A counterpart plug shall be engaged with the receptacle and shall not be held by any locking means. The wire bundles or cables attached to the receptacle shall be clamped to nonvibrating points at least 8 inches from the rear of the receptacle. The wire bundles or cables attached to the plug shall be clamped to a vibrating point  $4 \pm 1/2$  inches from the rear of the plug. The clamping length shall be chosen to avoid resonance of the wire bundles or cables. To eliminate possible wire breakage when testing connectors wired with No. 28 AWG wire, a strain relief clamp that mounts directly to the connector and reduces the clamping length of the wire bundle to a minimum is permitted.

4.7.16 Shock (see 3.5.15). Mated connectors shall be subjected to Test Condition E, Method 2004 of MIL-STD-1344. One shock shall be applied in each direction of the three major axes of the connectors. Receptacles shall be mounted similar to the mounting of 4.7.14.1. Plugs shall be engaged with the receptacles and shall not be held by any locking means. All contacts shall be wired in series with a minimum of 100 milliamperes of current allowed to flow. The wire bundles or cables shall be clamped to structures that move. A minimum of 8 inches of wire or cable shall be unsupported behind the rear of the receptacle and  $4 \pm 1/2$  inches of wire or cable shall be unsupported behind the rear of the plug. A suitable instrument shall be employed to indicate any discontinuity or interruption of current flow. Requirement shall be as specified in 3.5.15.

4.7.17 Durability (see 3.5.16). Connectors shall be tested in accordance with Method 2016 of MIL-STD-1344. The following details apply:

- a. Mated and unmated 500 times at a rate of  $200 \pm 100$  cycles per hour.
- b. After 500 cycles mated connectors shall be subjected to salt spray.

4.7.18 Salt spray (corrosion) (see 3.5.17). Mated connectors shall be subjected to a salt spray test in accordance with Method 1001, Condition B, of MIL-STD-1344. After exposure, connectors shall be thoroughly washed with tap water to remove all salt deposits and then shall be dried in a circulating air oven at temperature of  $38^{\circ}\text{C} \pm 3^{\circ}\text{C}$  for a period of 12 hours. They shall then be visually examined for evidence of corrosion and subjected to the contact resistance test of 4.7.10 and the mating and unmating force test of 4.7.5. After completion of test, connectors shall conform to the requirements of 3.5.4, 3.5.5, and 3.5.9.

4.7.19 Oversize pin exclusion (not applicable for crimp contacts) (see 3.5.18). A hardened steel oversize pin, as specified in 3.5.18, shall be placed in a position centered and parallel to the axis of the socket contact. A 12 ounce axial force shall then be applied tending to force the test pin into the socket contact. After completion of the test, the contacts shall be subjected to the contact resistance test in accordance with 4.7.10. This test shall be performed on 20 percent or a minimum of four, of the socket contacts in each connector.

4.7.20 Resistance to test probe damage (nonremovable contacts) (see 3.5.19). Socket contacts shall be tested in accordance with Method 2006 of MIL-STD-1344. The following details shall apply:

- a. The test shall be performed on 20 percent of the contacts, or a minimum of four contacts.
- b. After testing, the contacts shall meet the requirements of 3.5.19 (contact engagement and separation).
- c. Type 1 or Type 2 contact holding device.
- d. Probe damage tool shall be inserted into the contact to the following depths:

Contact size	Holding fixture	
	Type 1	Type 2
20	.202 $\pm$ .005, .077 $\pm$ .005	.250 $\pm$ .005, .125 $\pm$ .007
IDC 20	.202 $\pm$ .005, .077 $\pm$ .005	.250 $\pm$ .005, .125 $\pm$ .007

NOTE: Dimensions are in inches.

e. The diameter of the handle (.190) is not applicable.

4.7.21 Fluid immersion (see 3.5.20). Connectors shall be tested in accordance with Method 1016 of MIL-STD-1344. The following details apply:

- Hydraulic fluid conforming to MIL-H-5606 - 20 hours.
- Lubricating oil conforming to MIL-L-23699 - 20 hours.

4.7.22 Insert retention (see 3.5.21). Unmated connectors shall be tested in accordance with Method 2010 of MIL-STD-1344:

- Force to be applied: 10 lbf/in<sup>2</sup> per second until pressure specified in 3.5.21 is reached.
- For Classes G, D, M, and N connectors, the wired contacts may be removed for convenience of testing.

4.7.23 Solderability (see 3.5.23). Each terminal, except wrappost and crimp, shall be tested in accordance with Method 208 of MIL-STD-202.

4.7.24 Contact pin strength (see 3.5.22). Nonremovable contacts shall be mounted in a suitable fixture and a force of 2 pounds  $\pm$  1 ounce shall be applied to the end of the pin as shown in FIGURE 3. The maximum rate of travel of the head of the testing machine shall not exceed 1 inch per minute. Maximum loading time shall not exceed 1 minute. The permanent set shall be the difference between the initial and final position of the extreme pin tip, immediately after load removal and shall not exceed the limits specified in 3.5.22.

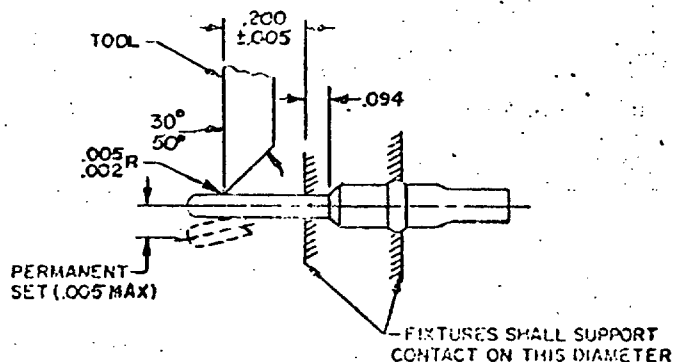


FIGURE 3. Contact strength test.

4.7.25 Thermal vacuum outgassing (Classes D, K and M). All non-metallic materials, including lubricants, used in the manufacture of these connectors shall be tested in accordance with SP-R-0022 to determine the maximum TML of the original specimen mass and the VCM content of the original specimen mass. For the purpose of determining TML and VCM of connectors, the original specimen mass shall be the assembled connector mass excluding metallic parts. The TMC and VCM for the connectors may be determined by testing the specific materials of the connector and calculating the loss for the connector.

## 5. PACKAGING

5.1 Packaging requirements. The requirements for packaging shall be in accordance with MIL-C-55330.

## 6. NOTES

6.1 Intended use. These connectors are intended for general military use. The classes and types of connectors are intended for application as follows. Connector installations should be designed to assure that connectors are mated within the limits prescribed by 3.4.5.

a. Classes G and N connectors are intended for use in nonenvironment-resisting applications where the operating temperature range of -55° to +125°C is experienced. Crimp contact connectors have the additional advantage of possessing removable crimp-type contacts.

b. Class N connectors are intended for use in applications wherein presence of residual magnetism must be held to very low levels to avoid interference with nearby sensitive instrumentation.

c. Class H receptacles are intended for use in applications wherein atmospheric pressures must be contained by the connectors across the wall or panels on which they are mounted. If air leakage requirements are critical, a Class H connector should be used.

d. Crimp contact connectors shall have contacts present in all positions when the connector is installed.

e. Class D, K, and M connectors are for high reliability spaceborne applications.

f. Connector installations should be designed to assure that connectors are mated within the limits prescribed by 3.4.5.

6.2 Ordering data. Acquisition documents should specify the following:

a. Title, number, and date of this specification

b. Title, number, and date of the applicable specification sheet and the complete part number (see 3.1)

c. Levels of preservation and packaging and packing, and applicable marking (see Section 5).

6.3 Qualification. With respect to products requiring qualification, awards will be made only for products which are at the time set for opening of bids, qualified for inclusion in the applicable qualified products list, whether or not such products have actually been so listed by that date. The attention of the contractors is called to this requirement, and manufacturers are urged to arrange to have products that they propose to offer to the Federal Government tested for qualification in order that they may be eligible to be awarded contracts or orders for the products covered by this specification. The activity responsible for the qualified products list is Naval Electronic Systems Command, ATTN: EL EX 8111, Department of the Navy, Washington, DC 20363. However, information pertaining to qualification of products may be obtained from the Defense Electronics Supply Center (DESC-E), Engineering Standardization Directorate, Dayton, OH 45444.

6.4 Copyright notice. All information disclosed in this specification and related specification sheets and military standard which is or may be copyrighted by ITT Cannon Electric is reproduced herein with the express permission of the copyright owner.

6.5 Definitions.

6.6.1 Overall finish. A finish having a specified minimum thickness applied over the entire surface area (such as, barrel plating technique or other nonselective plating technique, and so forth).

6.6.2 Localized finish. A finish having a specified minimum thickness applied to a definite area, (such as, clad, inlay, welded dot, selective plating technique, and so forth).

6.6.3 Gold finish. A finish having an unspecified thickness of gold not requiring a measurement of thickness.

6.7 Changes from previous issue. Asterisks are not used in this revision to identify changes with respect to the previous issue due to the extensiveness of the changes.

Custodians:

Army - CR  
Navy - EC  
Air Force - 85

Preparing activity:

Navy - EC  
(Project 5935-3268)

Review activities:

Army - MI, AR, AV  
Navy - AS  
Air Force - 11, 99  
DLA - ES

User activities:

Army - ME, AT  
Navy - CG, MC, OS

Agent:

DLA - ES

# STANDARDIZATION DOCUMENT IMPROVEMENT PROPOSAL

(See Instructions - Reverse Side)

1. DOCUMENT NUMBER

MIL-C-24308B

2. DOCUMENT TITLE

Connectors, Electric, Rectangular, Abnenvronmentel,  
Miniature, Polarized Shell, Rack and Panel

3a. NAME OF SUBMITTING ORGANIZATION

4. TYPE OF ORGANIZATION (Mark one)

☐

VENDOR

☐

USER

☐

MANUFACTURER

☐

OTHER (Specify):

b. ADDRESS (Street, City, State, ZIP Code)

## 5. PROBLEM AREAS

a. Paragraph Number and Wording:

b. Recommended Wording:

c. Reason/Rationale for Recommendation:

## 6. REMARKS

7a. NAME OF SUBMITTER (Last, First, MI) - Optional

b. WORK TELEPHONE NUMBER (Include Area Code) - Optional

c. MAILING ADDRESS (Street, City, State, ZIP Code) - Optional

8. DATE OF SUBMISSION (YYMMDD)

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